

TLS205B0

Low Dropout Low Noise Linear Voltage Post Regulator

TLS205B0EJV
TLS205B0EJV33

Data Sheet

Rev. 1.1, 2014-06-03

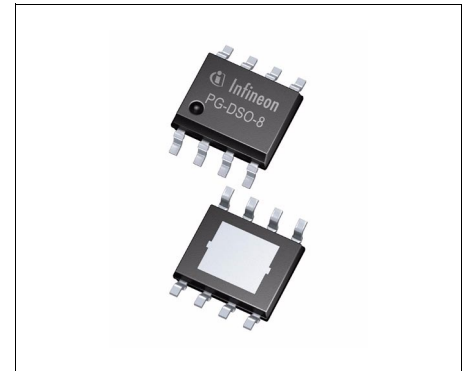
Automotive Power



1 Overview

Features

- Low Noise down to $24 \mu V_{RMS}$ (BW=10 Hz to 100 kHz)
- 500 mA Current Capability
- Low Quiescent Current: 30 μA
- Wide Input Voltage Range: 2.3 V to 20 V
- Low Dropout Voltage: 320 mV
- Very low Shutdown Current: < 1 μA
- No Protection Diodes Needed
- Fixed Output Voltage: 3.3 V
- Adjustable Version with Output from 1.22 V to 20 V
- Stable with $\geq 3.3 \mu F$ Output Capacitor
- Stable with Aluminium, Tantalum or Ceramic
- Reverse Polarity Protection
- No Reverse Current
- Overcurrent and Overtemperature Protected
- PG-DSO-8 Exposed Pad Package
- Suitable for Use in Automotive Electronics as Post Regulator
- Green Product (RoHS compliant)
- AEC Qualified



PG-DSO-8 Exposed Pad

The TLS205B0 is a micropower, low noise, low dropout voltage regulator. The device is capable of supplying an output current of 500 mA with a dropout voltage of 320 mV. Designed for use in battery-powered systems, the low quiescent current of 30 μA makes it an ideal choice.

A key feature of the TLS205B0 is its low output noise. By adding an external 10 nF bypass capacitor output noise values down to $24 \mu V_{RMS}$ over a 10 Hz to 100 kHz bandwidth can be reached. The TLS205B0 voltage regulator is stable with output capacitors as small as 3.3 μF . Small ceramic capacitors can be used without the series resistance required by many other linear voltage regulators.

Internal protection circuitry includes reverse battery protection, current limiting and reverse current protection. The TLS205B0 comes as fixed output voltage variant 3.3 V as well as adjustable device with a 1.22 V reference voltage. It is available in a PG-DSO-8 Exposed Pad package.

Product Overview

Type	Package	Marking
TLS205B0EJV	PG-DSO-8 Exposed Pad	205B0V
TLS205B0EJV33	PG-DSO-8 Exposed Pad	205B0V33

2 Block Diagram

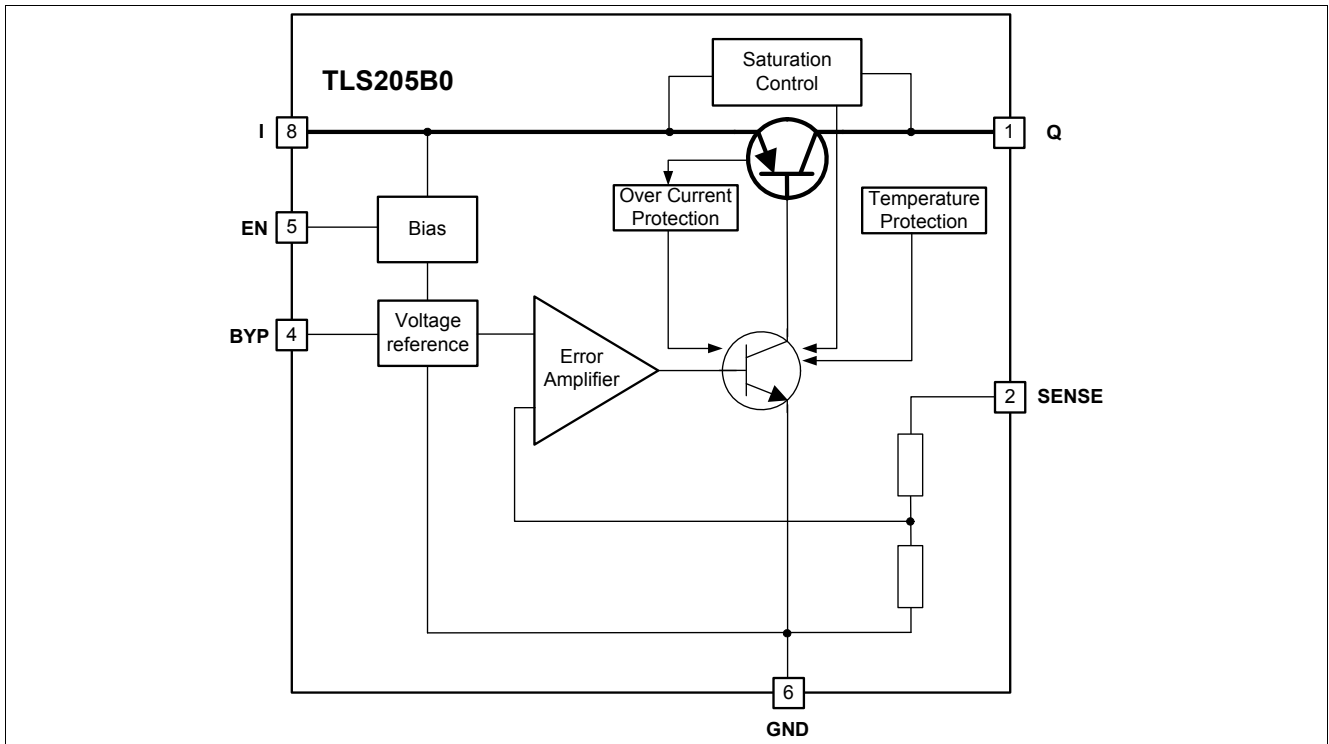


Figure 1 Block Diagram TLS205B0 fixed voltage version

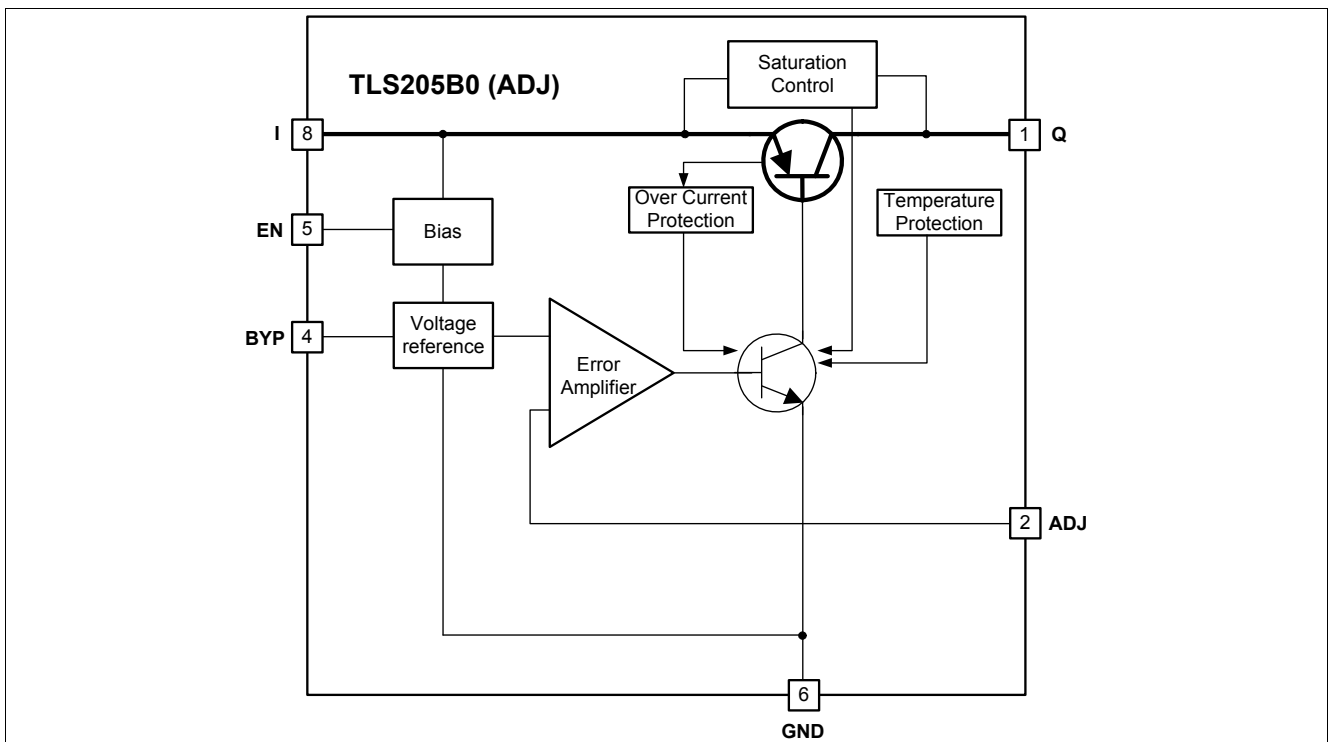


Figure 2 Block Diagram TLS205B0 adjustable version

3 Pin Configuration

3.1 Pin Assignment

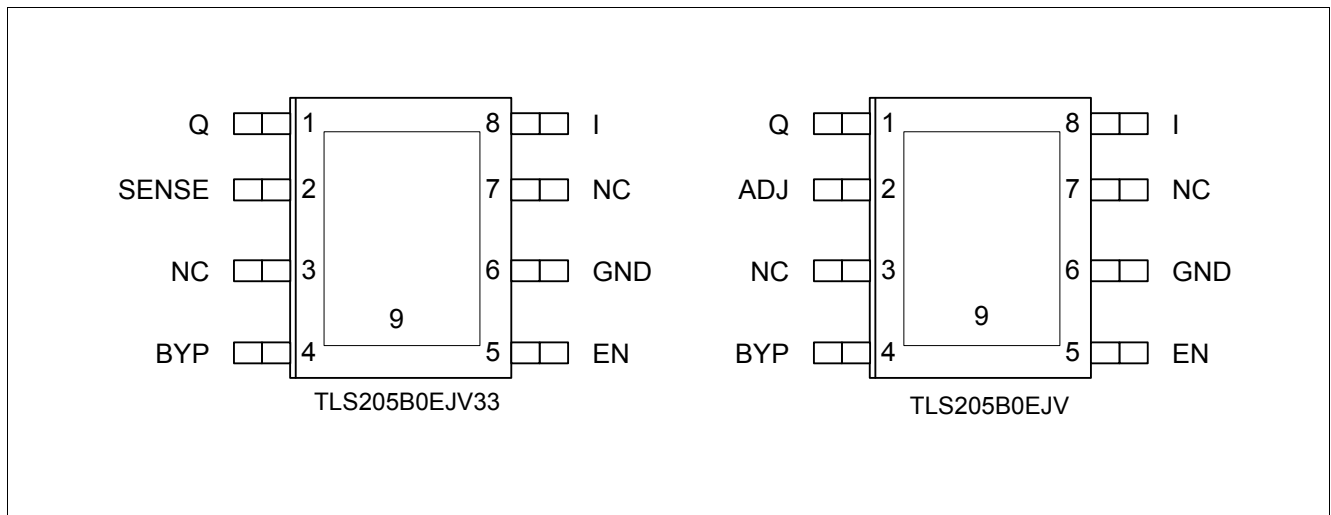


Figure 3 Pin Configuration of TLS205B0 in PG-DSO-8 Exposed Pad for fixed voltage and adjustable version

3.2 Pin Definitions and Functions

Pin	Symbol	Function
1	Q	Output. Supplies power to the load. For this pin a minimum output cap of 3.3 μF is required to prevent oscillations. Larger output capacitors may be required for applications with large transient loads in order to limit peak voltage transients or when the regulator is applied in conjunction with a bypass capacitor. For more details please refer to “Application Information” on Page 23.
2	SENSE (fix voltage version)	Output Sense. For the fixed voltage version the SENSE pin is the input to the error amplifier. This allows to achieve an optimized regulation performance in case of small voltage drops R_p that occur between regulator and load. In applications where such drops are relevant they can be eliminated by connecting the SENSE pin directly at the load. In standard configuration the SENSE pin can be directly connected to Q. For further details please refer to the section “Kelvin Sense Connection” on Page 24.
2	ADJ (adjustable version)	Adjust. For the adjustable version the ADJ pin is the input to the error amplifier. The ADJ pin voltage is 1.22 V referenced to ground and allows a output voltage range from 1.22 V to $20\text{ V} - V_{\text{DR}}$. The ADJ pin is internally clamped to $\pm 7\text{ V}$. Please note that the bias current of the ADJ pin is flowing into the pin. Its typical value of 60 nA shows a good stability with temperature. For further details please refer to Typical Performance Graph “Adjust Pin Bias Current versus Junction Temperature T_j” on Page 19.
3, 7	NC	No Connect. The NC Pins have no connection to any internal circuitry. Connect either to GND or leave open.
4	BYP	Bypass. The BYP pin is used to bypass the reference of the TLS205B0 to achieve low noise performance. The BYP-pin is clamped internally to $\pm 0.6\text{ V}$ (i.e. one V_{BE}). A small capacitor from the output Q to the BYP pin will bypass the reference to lower the output voltage noise ¹⁾ . If not used this pin must be left unconnected.
5	EN	Enable. With the EN pin the TLS205B0 can be put into a low power shutdown state. The output will be off when the EN is pulled low. The EN pin can be driven either by 3.3 V or 5 V logic or as well by open-collector logic with pull-up resistor. The pull-up resistor is required to supply the pull-up current of the open-collector gate ²⁾ and the EN pin current ³⁾ . Please note that if the EN pin is not used it must be connected to V_i . It must not be left floating.
6	GND	Ground. For the ADJ version connect the bottom of the output voltage setting resistor divider directly to the GND pin for optimum load regulation performance.

Pin Configuration

Pin	Symbol	Function
8	I	Input. The device is supplied by the input pin I. A capacitor at the input pin is required if the device is more than 6 inches away from the main input filter capacitor or if a non-negligible inductance is present at the input I ⁴⁾ . The TLS205B0 is designed to withstand reverse voltages on the input pin I with respect to GND and output Q. In the case of reverse input (e.g. due to a wrongly attached battery) the device will act as if there is a diode in series with its input. In this way there will be no reverse current flowing into the regulator and no reverse voltage will appear at the load. Hence, the device will protect both - the device itself and the load.
9	Tab	Exposed Pad. To ensure proper thermal performance, solder Pin 9 to the PCB ground and tie directly to Pin 6 (GND).

- 1) A maximum value of 10 nF can be used for reducing output voltage noise over the bandwidth from 10 Hz to 100 kHz.
- 2) Normally several microamperes.
- 3) Typical value is 1 μ A.
- 4) In general the output impedance of a battery rises with frequency, so it is advisable to include a bypass capacitor in battery-powered circuits. Depending on actual conditions an input capacitor in the range of 1 to 10 μ F is sufficient.

4 General Product Characteristics

4.1 Absolute Maximum Ratings

Table 1 Absolute Maximum Ratings ¹⁾

$T_j = -40\text{ °C}$ to $+150\text{ °C}$; all voltages with respect to ground, positive current flowing into pin (unless otherwise specified)

Parameter	Symbol	Values			Unit	Note / Test Condition	Number
		Min.	Typ.	Max.			
Input Voltage							
Voltage	V_I	-20	–	20	V	–	P_4.1.1
Output Voltage							
Voltage	V_Q	-20	–	20	V	–	P_4.1.2
Input to Output Differential Voltage	$V_I - V_Q$	-20	–	20	V	–	P_4.1.3
Sense Pin							
Voltage	V_{SENSE}	-20	–	20	V	–	P_4.1.4
ADJ Pin							
Voltage	V_{ADJ}	-7	–	7	V	–	P_4.1.5
BYP Pin							
Voltage	V_{BYP}	-0.6	–	0.6	V		P_4.1.6
Enable Pin							
Voltage	V_{EN}	-20	–	20	V	–	P_4.1.7
Temperatures							
Junction Temperature	T_j	-40	–	150	°C	–	P_4.1.8
Storage Temperature	T_{stg}	-55	–	150	°C	–	P_4.1.9
ESD Susceptibility							
All Pins	V_{ESD}	-2	–	2	kV	HBM ²⁾	P_4.1.10
All Pins	V_{ESD}	-1	–	1	kV	CDM ³⁾	P_4.1.11

1) Not subject to production testing, specified by design.

2) ESD susceptibility, HBM according to ANSI/ESDA/JEDEC JS001 (1.5 kΩ, 100 pF)

3) ESD susceptibility, Charged Device Model "CDM" according JEDEC JESD22-C101

Notes

1. Stresses above the ones listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.
2. Integrated protection functions are designed to prevent IC destruction under fault conditions described in the data sheet. Fault conditions are considered as "outside" normal operating range. Protection functions are not designed for continuous repetitive operation.

4.2 Functional Range

Table 2 Functional Range

Parameter	Symbol	Values			Unit	Note / Test Condition	Number
		Min.	Typ.	Max.			
Input Voltage Range (fix voltage version)	V_I	$V_{Q,nom} + 0.5\text{ V}$	–	20	V	–	P_4.2.1
Input Voltage Range (adjustable voltage version)	V_I	2.3	–	20	V	– ¹⁾	P_4.2.2
Output Capacitor's Requirements for Stability	C_Q	3.3	–	–	μF	$C_{BYP} = 0\text{ nF}$ ²⁾	P_4.2.3
Output Capacitor's Requirements for Stability	C_Q	6.8	–	–	μF	$0 < C_{BYP} \leq 10\text{ nF}$ ²⁾	P_4.2.4
ESR	ESR	– ³⁾	–	3	Ω	– ²⁾	P_4.2.5
Operating Junction Temperature	T_j	-40	–	125	$^{\circ}\text{C}$	–	P_4.2.6

- 1) For the TLS205B0 adjustable version the minimum limit of the functional range V_I is tested and specified with the ADJ- pin connected to the Q pin.
- 2) for further details see corresponding graph.
- 3) $C_{BYP} = 0\text{ nF}$, $C_Q \geq 3.3\text{ }\mu\text{F}$; please note that for cases where a bypass capacitor at BYP is used – depending on the actual applied capacitance of C_Q and C_{BYP} a minimum requirement for ESR of C_Q may apply.

Note: Within the functional or operating range, the IC operates as described in the circuit description. The electrical characteristics are specified within the conditions given in the Electrical Characteristics table.

4.3 Thermal Resistance

Note: This thermal data was generated in accordance with JEDEC JESD51 standards. For more information, go to www.jedec.org.

Table 3 Thermal Resistance ¹⁾

Parameter	Symbol	Values			Unit	Note / Test Condition	Number
		Min.	Typ.	Max.			
TLS205B0EJ (PG-DSO-8 Exposed Pad)							
Junction to Case	R_{thJC}	–	7.0	–	K/W	–	P_4.3.1
Junction to Ambient	R_{thJA}	–	39	–	K/W	– ²⁾	P_4.3.2
Junction to Ambient	R_{thJA}	–	155	–	K/W	Footprint only ³⁾	P_4.3.3
Junction to Ambient	R_{thJA}	–	66	–	K/W	300 mm ² heatsink area on PCB ³⁾	P_4.3.4
Junction to Ambient	R_{thJA}	–	52	–	K/W	600 mm ² heatsink area on PCB ³⁾	P_4.3.5

- 1) Not subject to production test, specified by design.
- 2) Specified R_{thJA} value is according to Jedec JESD51-2,-5,-7 at natural convection on FR4 2s2p board; The Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm board with 2 inner copper layers (2 x 70 μm Cu, 2 x 35 μm Cu). Where applicable a thermal via array under the exposed pad contacted the first inner copper layer.
- 3) Specified R_{thJA} value is according to JEDEC JESD 51-3 at natural convection on FR4 1s0p board; The Product (Chip+Package) was simulated on a 76.2 x 114.3 x 1.5 mm³ board with 1 copper layer (1 x 70 μm Cu).

5 Electrical Characteristics

Table 4 Electrical Characteristics

-40 °C < T_j < 125 °C; all voltages with respect to ground; positive current defined flowing out of pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note / Test Condition	Number
		Min.	Typ.	Max.			
Minimum Operating Voltage	$V_{I,min}$	–	1.8	2.3	V	$I_Q = 500 \text{ mA}$ ^{1) 2) 3)}	P_5.0.1
Output Voltage ⁴⁾							
TLS205B0EJV33	V_Q	3.220	3.30	3.380	V	$1 \text{ mA} < I_Q < 500 \text{ mA}$; $4.3 \text{ V} < V_I < 20 \text{ V}$	P_5.0.2
TLS205B0EJV	V_Q	1.190	1.220	1.250	V	$1 \text{ mA} < I_Q < 500 \text{ mA}$; $2.3 \text{ V} < V_I < 20 \text{ V}$ ³⁾	P_5.0.3
Line Regulation							
TLS205B0EJV33	ΔV_Q	–	1	20	mV	$\Delta V_I = 3.8 \text{ V to } 20 \text{ V}$; $I_Q = 1 \text{ mA}$	P_5.0.4
TLS205B0EJV	ΔV_Q	–	1	20	mV	$\Delta V_I = 2.0 \text{ V to } 20 \text{ V}$; $I_Q = 1 \text{ mA}$ ³⁾	P_5.0.5
Load Regulation							
TLS205B0EJV33	ΔV_Q	–	9	22	mV	$T_J = 25 \text{ °C}$; $V_I = 4.3 \text{ V}$; $\Delta I_Q = 1 \text{ to } 500 \text{ mA}$	P_5.0.6
TLS205B0EJV33	ΔV_Q	–	–	38	mV	$V_I = 4.3 \text{ V}$; $\Delta I_Q = 1 \text{ to } 500 \text{ mA}$	P_5.0.7
TLS205B0EJV	ΔV_Q	–	4	8	mV	$T_J = 25 \text{ °C}$; $V_I = 2.3 \text{ V}$; $\Delta I_Q = 1 \text{ to } 500 \text{ mA}$ ³⁾	P_5.0.8
TLS205B0EJV	ΔV_Q	–	–	14	mV	$V_I = 2.3 \text{ V}$; $\Delta I_Q = 1 \text{ to } 500 \text{ mA}$ ³⁾	P_5.0.9
Dropout Voltage ^{2) 5) 6)}							
Dropout Voltage	V_{DR}	–	130	190	mV	$I_Q = 10 \text{ mA}$; $V_I = V_{Q,nom}$; $T_J = 25 \text{ °C}$	P_5.0.10
Dropout Voltage	V_{DR}	–	–	250	mV	$I_Q = 10 \text{ mA}$; $V_I = V_{Q,nom}$	P_5.0.11
Dropout Voltage	V_{DR}	–	170	220	mV	$I_Q = 50 \text{ mA}$; $V_I = V_{Q,nom}$; $T_J = 25 \text{ °C}$	P_5.0.12
Dropout Voltage	V_{DR}	–	–	320	mV	$I_Q = 50 \text{ mA}$; $V_I = V_{Q,nom}$	P_5.0.13
Dropout Voltage	V_{DR}	–	200	240	mV	$I_Q = 100 \text{ mA}$; $V_I = V_{Q,nom}$; $T_J = 25 \text{ °C}$	P_5.0.14
Dropout Voltage	V_{DR}	–	–	340	mV	$I_Q = 100 \text{ mA}$; $V_I = V_{Q,nom}$	P_5.0.15
Dropout Voltage	V_{DR}	–	320	350	mV	$I_Q = 500 \text{ mA}$; $V_I = V_{Q,nom}$; $T_J = 25 \text{ °C}$	P_5.0.16
Dropout Voltage	V_{DR}	–	–	450	mV	$I_Q = 500 \text{ mA}$; $V_I = V_{Q,nom}$	P_5.0.17
Quiescent Current							
Quiescent Current ^{5) 7)} (Active-Mode, EN-pin high)	I_Q	–	30	60	μA	$V_I = V_{Q,nom}$; $I_Q = 0 \text{ mA}$	P_5.0.18

Table 4 Electrical Characteristics (cont'd)

-40 °C < T_j < 125 °C; all voltages with respect to ground; positive current defined flowing out of pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note / Test Condition	Number
		Min.	Typ.	Max.			
Quiescent Current (Off-Mode, EN-pin low)	I _q	–	0.1	1	µA	V _I = 6 V ; V _{EN} = 0 V ; T _J = 25 °C	P_5.0.19
GND Pin Current ^{5) 7)}							
GND Pin Current	I _{GND}	–	50	100	µA	V _I = V _{Q,nom} ; I _Q = 1 mA	P_5.0.20
GND Pin Current	I _{GND}	–	300	850	µA	V _I = V _{Q,nom} ; I _Q = 50 mA	P_5.0.21
GND Pin Current	I _{GND}	–	0.7	2.2	mA	V _I = V _{Q,nom} ; I _Q = 100 mA	P_5.0.22
GND Pin Current	I _{GND}	–	3	8	mA	V _I = V _{Q,nom} ; I _Q = 250 mA	P_5.0.23
GND Pin Current	I _{GND}	–	11	22	mA	V _I = V _{Q,nom} ; I _Q = 500 mA ; T _J ≥ 25 °C	P_5.0.24
GND Pin Current	I _{GND}	–	11	31	mA	V _I = V _{Q,nom} ; I _Q = 500 mA ; T _J < 25 °C	P_5.0.25
Enable							
Enable Threshold High	V _{th,EN}	–	0.8	2.0	V	V _Q = Off to On	P_5.0.26
Enable Threshold Low	V _{tl,EN}	0.25	0.65	–	V	V _Q = On to Off	P_5.0.27
EN Pin Current ⁸⁾	I _{EN}	–	0.01	–	µA	V _{EN} = 0 V ; T _J = 25 °C	P_5.0.28
EN Pin Current ⁸⁾	I _{EN}	–	1	–	µA	V _{EN} = 20V ; T _J = 25 °C	P_5.0.29
Adjust Pin Bias Current ^{9) 10)}							
ADJ Pin Bias Current	I _{bias,ADJ}	–	60	–	nA	T _J = 25 °C	P_5.0.30
Output Voltage Noise ¹⁰⁾							
Output Voltage Noise TLS205B0EJV ¹¹⁾	e _{no}	–	41	–	µV _{RMS}	C _Q = 10 µF ; C _{BYP} = 10 nF ; I _Q = 500 mA ; BW = 10 Hz to 100 kHz	P_5.0.31
Output Voltage Noise TLS205B0EJV ¹¹⁾	e _{no}	–	28	–	µV _{RMS}	C _Q = 10 µF +250mΩ resistor in series; C _{BYP} = 10 nF ; I _Q = 500 mA ; BW = 10 Hz to 100 kHz	P_5.0.32
Output Voltage Noise TLS205B0EJV ¹¹⁾	e _{no}	–	29	–	µV _{RMS}	C _Q = 22 µF C _{BYP} = 10 nF ; I _Q = 500 mA ; BW = 10 Hz to 100 kHz	P_5.0.33
Output Voltage Noise TLS205B0EJV ¹¹⁾	e _{no}	–	24	–	µV _{RMS}	C _Q = 22 µF +250mΩ resistor in series; C _{BYP} = 10 nF ; I _Q = 500 mA ; BW = 10 Hz to 100 kHz	P_5.0.34

Electrical Characteristics
Table 4 Electrical Characteristics (cont'd)

-40 °C < T_j < 125 °C; all voltages with respect to ground; positive current defined flowing out of pin; unless otherwise specified.

Parameter	Symbol	Values			Unit	Note / Test Condition	Number
		Min.	Typ.	Max.			
Output Voltage Noise TLS205B0EJV33	e_{no}	–	45	–	μV_{RMS}	$C_Q = 10 \mu F$; $C_{BYP} = 10 nF$; $I_Q = 500 mA$; BW = 10 Hz to 100 kHz	P_5.0.35
Output Voltage Noise TLS205B0EJV33	e_{no}	–	35	–	μV_{RMS}	$C_Q = 10 \mu F$ +250m Ω resistor in series; $C_{BYP} = 10 nF$; $I_Q = 500 mA$; BW = 10 Hz to 100 kHz	P_5.0.36
Output Voltage Noise TLS205B0EJV33	e_{no}	–	33	–	μV_{RMS}	$C_Q = 22 \mu F$ $C_{BYP} = 10 nF$; $I_Q = 500 mA$; BW = 10 Hz to 100 kHz	P_5.0.37
Output Voltage Noise TLS205B0EJV33	e_{no}	–	30	–	μV_{RMS}	$C_Q = 22 \mu F$ +250m Ω resistor in series; $C_{BYP} = 10 nF$; $I_Q = 500 mA$; BW = 10 Hz to 100 kHz	P_5.0.38
Power Supply Ripple Rejection ¹⁰⁾							
Power Supply Ripple Rejection	$PSRR$	–	65	–	dB	$V_I - V_Q = 1.5 V$ (avg) ; $V_{RIPPLE} = 0.5 V_{pp}$; $f_r = 120 Hz$; $I_Q = 500 mA$	P_5.0.39
Output Current Limitation							
Output Current Limit	$I_{Q,limit}$	520	–	–	mA	$V_I = 7 V$; $V_Q = 0 V$	P_5.0.40
Output Current Limit	$I_{Q,limit}$	520	–	–	mA	$V_I = V_{Q,nom} + 1 V$ or 2.3 V ¹²⁾ ; $\Delta V_Q = -0.1 V$	P_5.0.41
Input Reverse Leakage Current							
Input Reverse Leakage	$I_{leak,rev}$	–	–	1	mA	$V_I = -20 V$; $V_Q = 0 V$	P_5.0.42
Reverse Output Current ¹³⁾							
Fixed Voltage Version	$I_{Reverse}$	–	10	20	μA	$V_Q = V_{Q,nom}$; $V_I < V_{Q,nom}$; $T_J = 25 ^\circ C$	P_5.0.43
Adjustable Voltage Version	$I_{Reverse}$	–	5	10	μA	$V_Q = 1.22 V$; $V_I < 1.22 V$; $T_J = 25 ^\circ C$ ³⁾	P_5.0.44

1) This parameter defines the minimum input voltage for which the device is powered up and provides the maximum output current of 500 mA. The output voltage of the adjustable version in this condition depends on the chosen setting of the external voltage divider as well as on the applied conditions – thus the device is either regulating its nominal output voltage or is in tracking mode. The 3.3 V fixed voltage version is by definition in tracking mode for such low input voltages.

2) For the adjustable version of the TLS205B0 the dropout voltage for certain output voltage / load conditions will be restricted by the minimum input voltage specification.

3) The adjustable version of the TLS205B0 is tested / specified for these conditions with the ADJ pin connected to the Q pin.

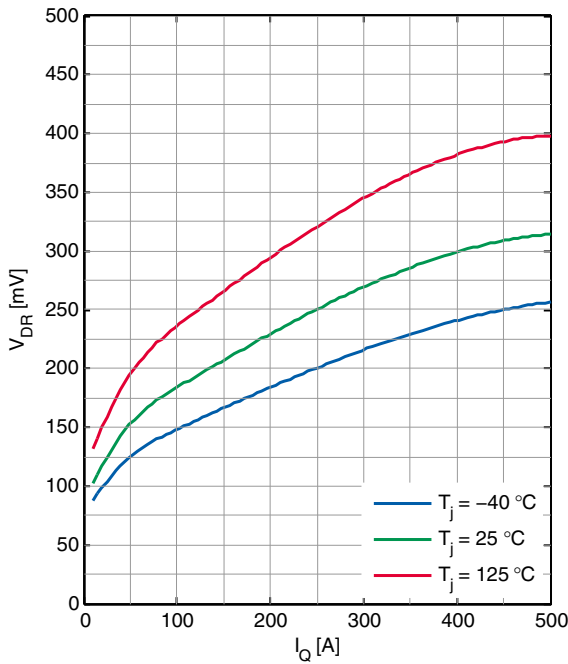
Electrical Characteristics

- 4) The operation conditions are limited by the maximum junction temperature. The regulated output voltage specification will only apply for conditions where the limit of the maximum junction temperature is fulfilled. It will therefore not apply for all possible combinations of input voltage and output current at a given output voltage. When operating at maximum input voltage, the output current must be limited for thermal reasons. The same holds true when operating at maximum output current where the input voltage range must be limited for thermal reasons.
- 5) To satisfy requirements for minimum input voltage, the TLS205B0 adjustable version is tested and specified for these conditions with an external resistor divider (two 250 k resistors) for an output voltage of 2.44 V. The external resistors will add a 5 μ A DC load on the output.
- 6) The dropout voltage is the minimum input to output voltage differential needed to maintain regulation at a specified output current. In dropout, the output voltage will be equal to $V_I - V_{DR}$
- 7) GND-pin current is tested with $V_I = V_{Q,nom}$ and a current source load. This means that this parameter is tested while being in the dropout region. The GND pin current will in most cases decrease slightly at higher input voltages - please also refer to the corresponding typical performance graphs.
- 8) The EN pin current flows into EN pin.
- 9) The ADJ pin current flows into ADJ pin.
- 10) Not subject to production test, specified by design.
- 11) ADJ pin connected to output pin Q.
- 12) Whichever of the two values of V_I is greater in order to also satisfy the requirements for $V_{I,min}$.
- 13) Reverse output current is tested with the I pin grounded and the Q pin forced to the rated output voltage. This current flows into the Q pin and out of the GND pin.

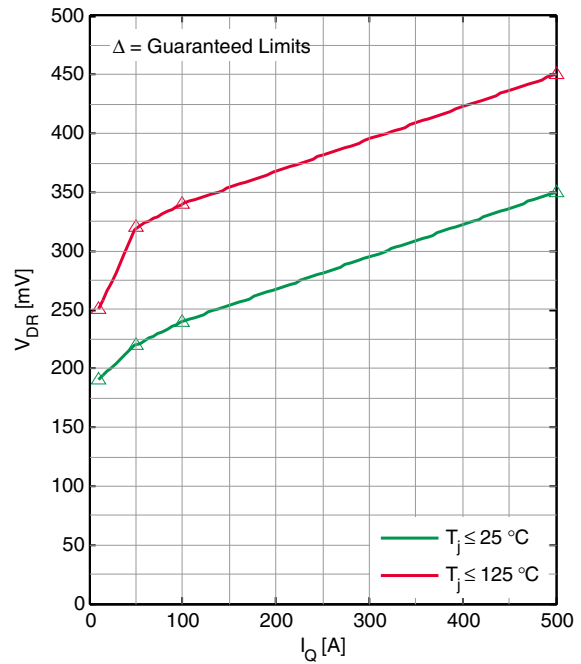
Note: The listed characteristics are ensured over the operating range of the integrated circuit. Typical characteristics specified mean values expected over the production spread. If not otherwise specified, typical characteristics apply at $T_A = 25^\circ\text{C}$ and the given supply voltage.

5.1 Typical Performance Characteristics

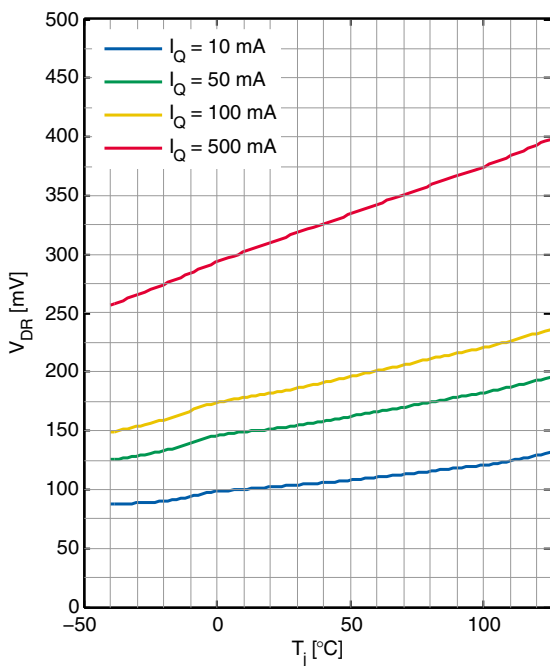
Dropout Voltage V_{DR} versus Output Current I_Q



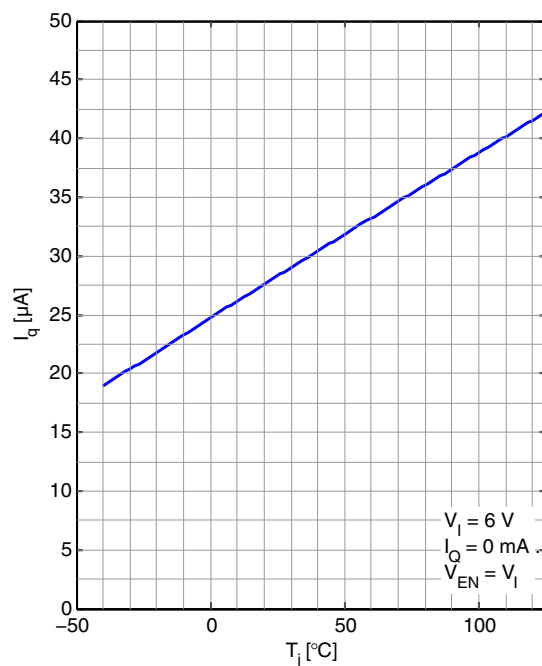
Guaranteed Dropout Voltage V_{DR} versus Output Current I_Q



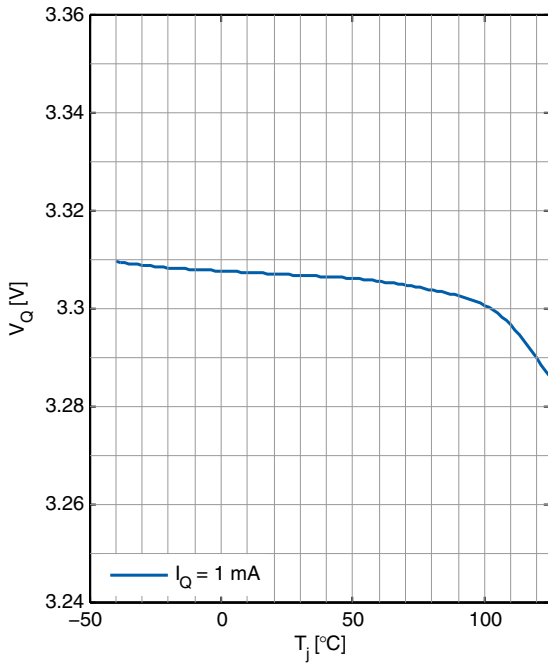
Dropout Voltage V_{DR} versus Junction Temperature T_j



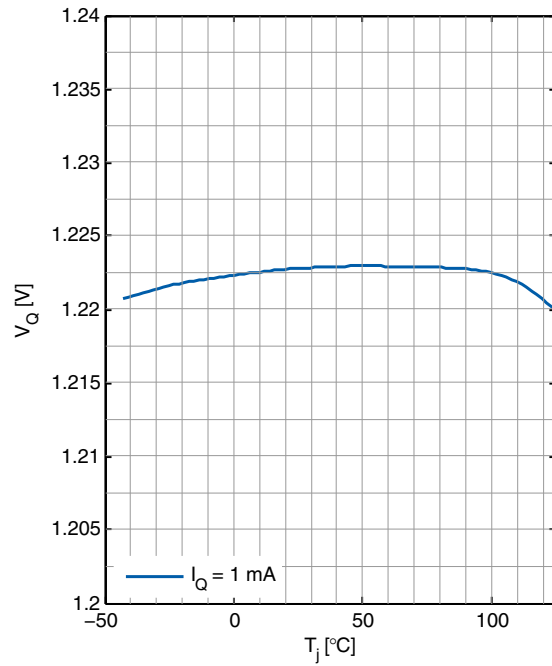
Quiescent Current versus Junction Temperature T_j



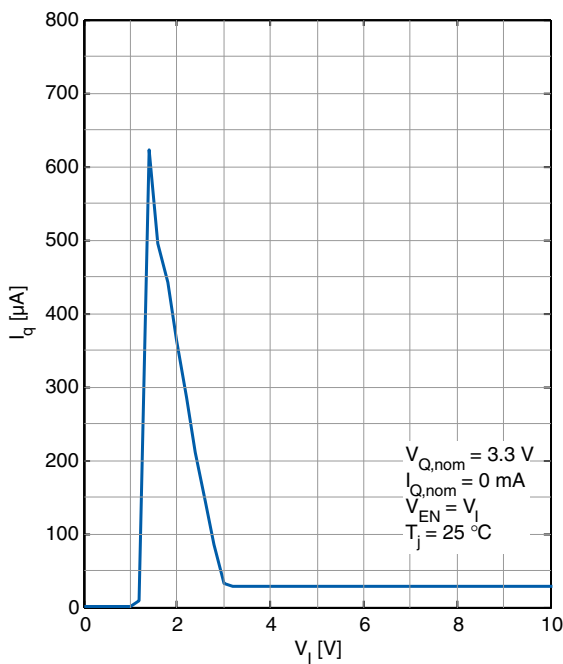
Output Voltage V_Q versus Junction Temperature T_J (TLS205B0EJV33)



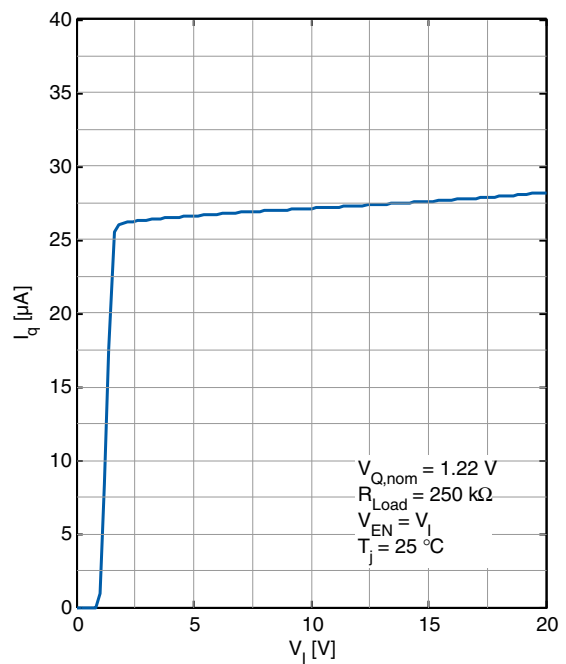
Output Voltage V_Q versus Junction Temperature T_J (TLS205B0EJV)



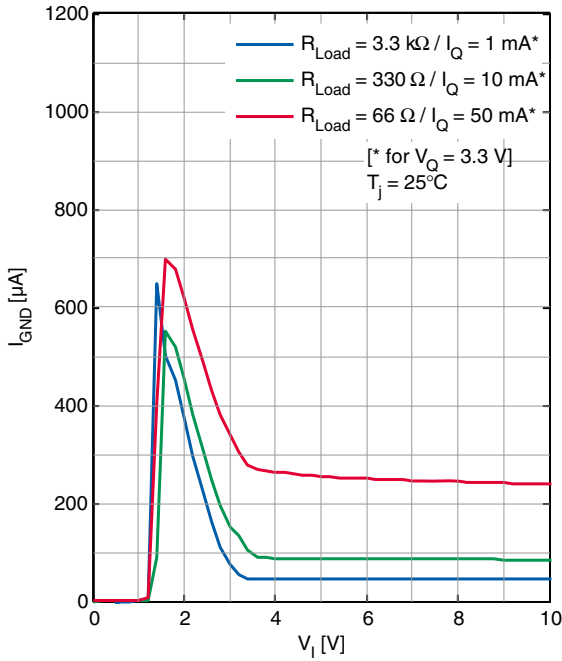
Quiescent Current I_q versus Input Voltage V_I (TLS205B0EJV33)



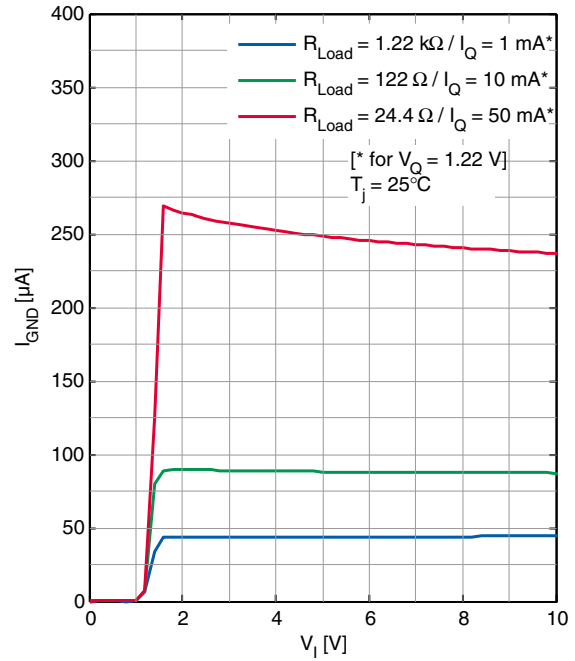
Quiescent Current I_q versus Input Voltage V_I (TLS205B0EJV)



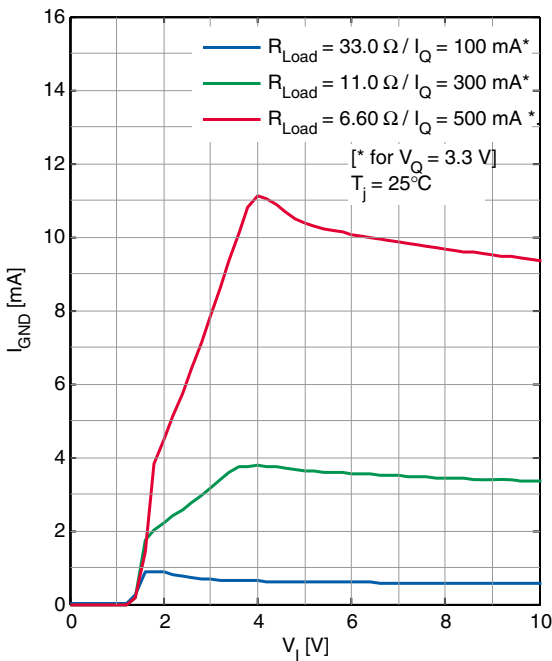
GND Pin Current I_{GND} versus Input Voltage V_I (TLS205B0EJV33)



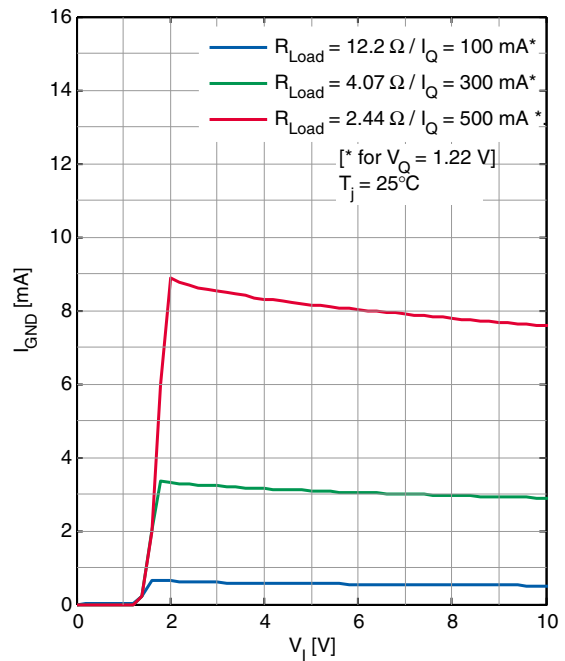
GND Pin Current I_{GND} versus Input Voltage V_I (TLS205B0EJV)



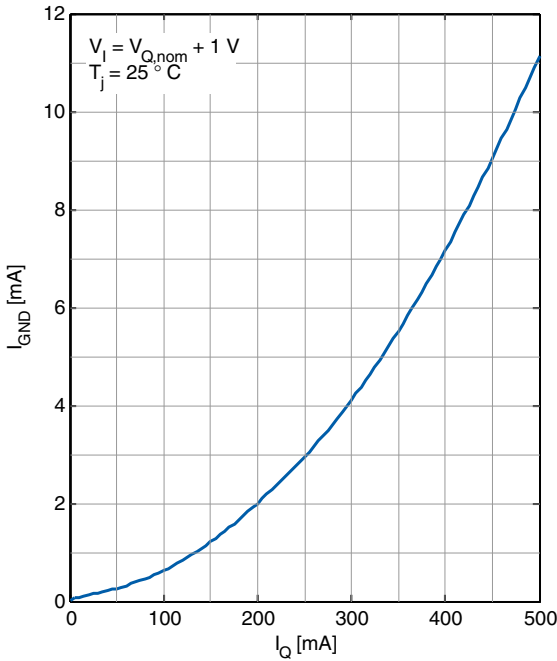
GND Pin Current I_{GND} versus Input Voltage V_I (TLS205B0EJV33)



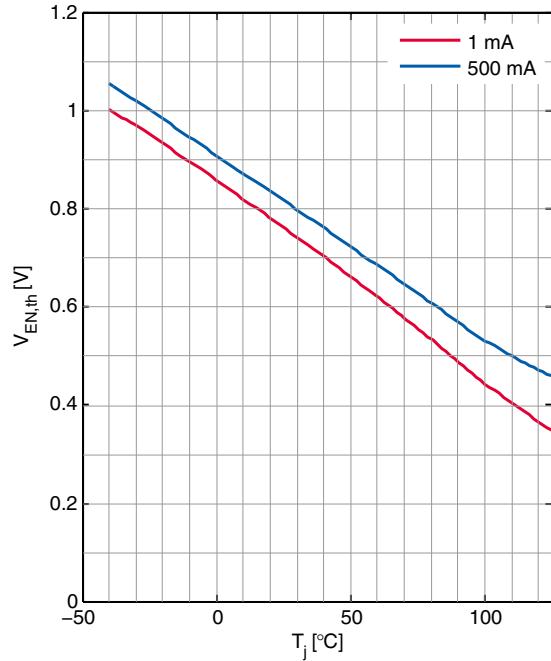
GND Pin Current I_{GND} versus Input Voltage V_I (TLS205B0EJV)



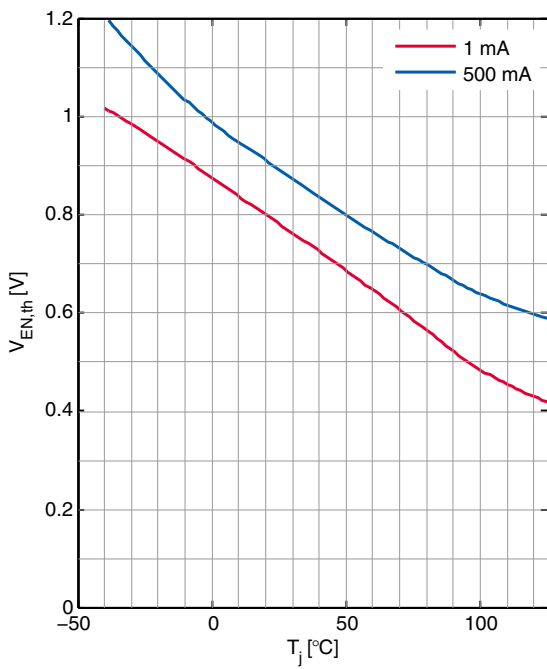
GND Pin Current I_{GND} versus Output Current I_Q



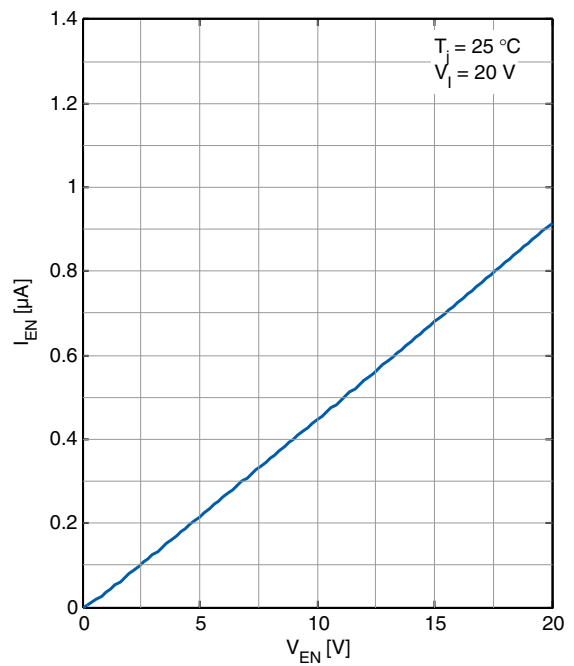
EN Pin Threshold (On-to-Off) versus Junction Temperature T_j



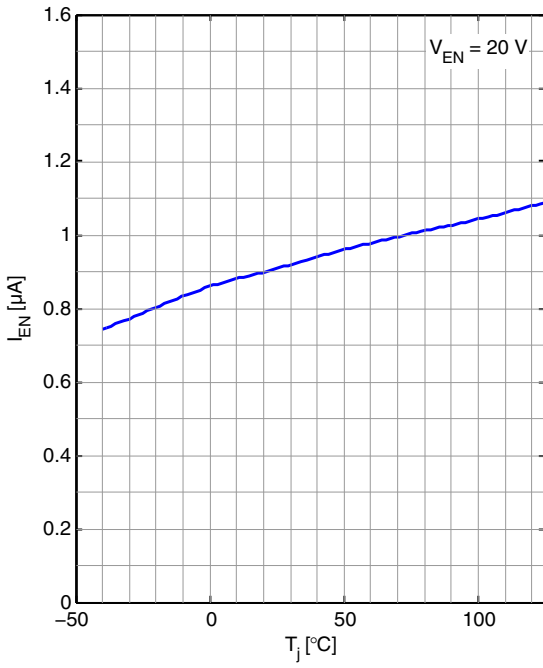
EN Pin Threshold (Off-to-On) versus Junction temperature T_j



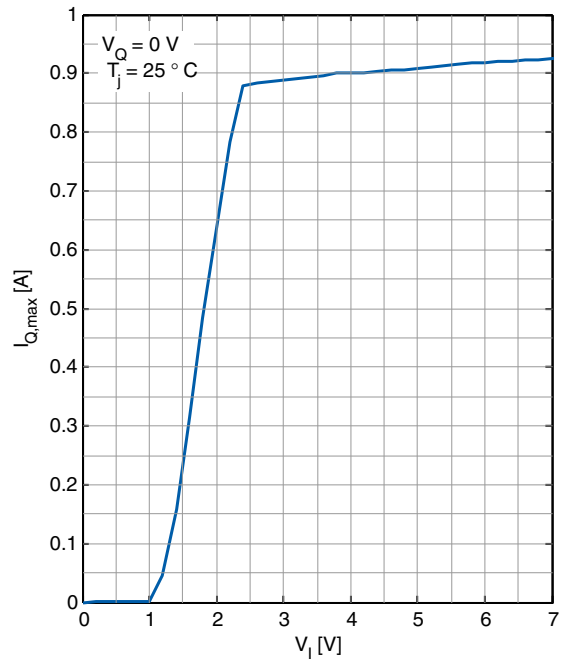
EN Pin Input Current (On-to-Off) versus EN Pin Voltage V_{EN}



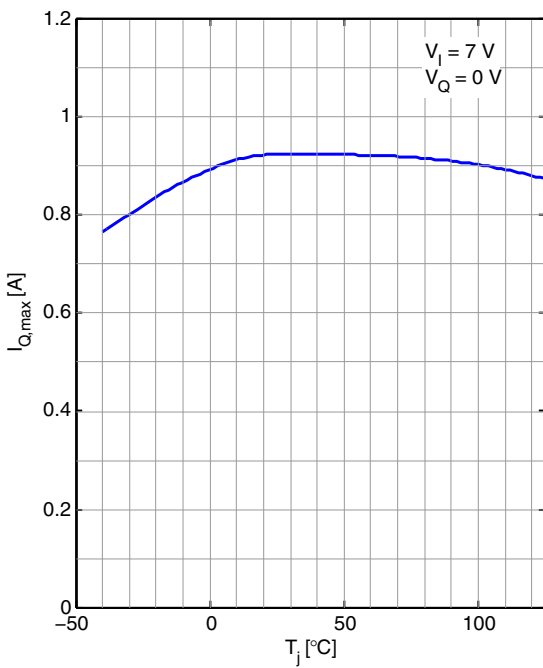
EN Pin Current versus Junction Temperature T_j



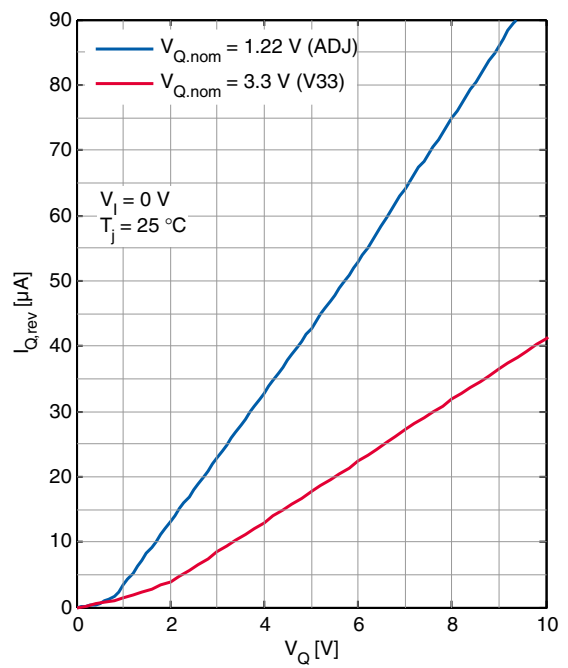
Current Limit versus Input Voltage V_I



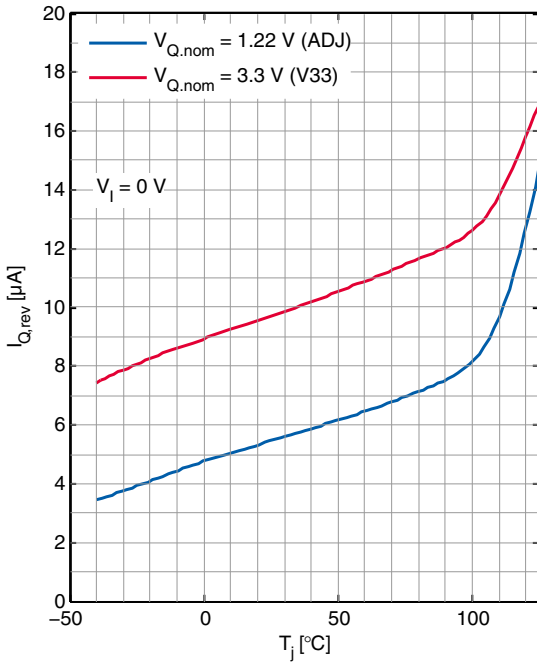
Current Limit versus Junction Temperature T_j



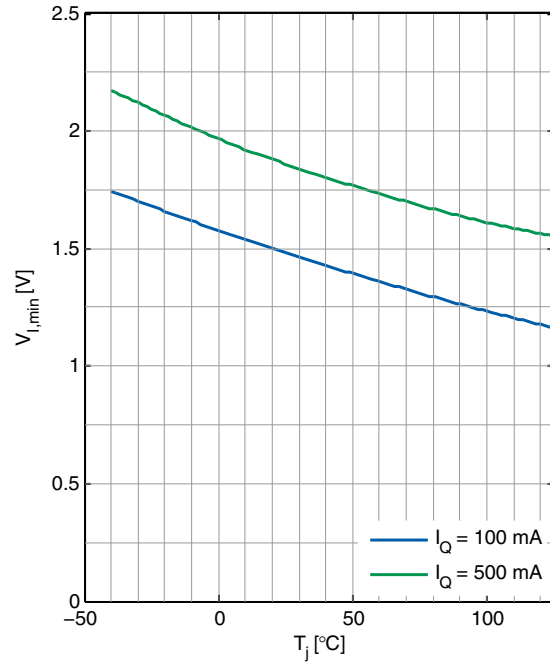
Reverse Output Current versus Output Voltage V_Q



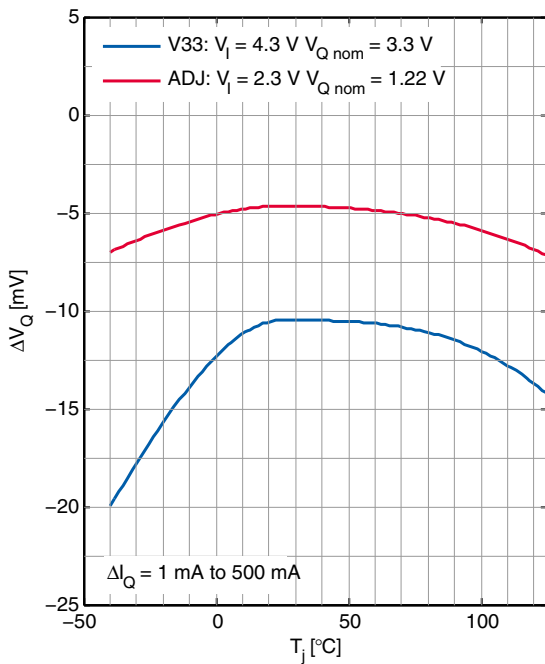
Reverse Output Current versus Junction Temperature T_J



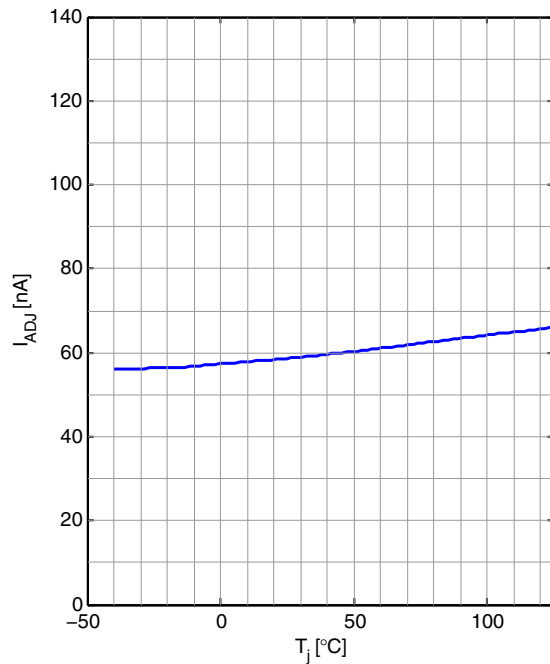
Minimum Input Voltage ¹⁾ versus Junction Temperature T_J



Load Regulation versus Junction Temperature T_J

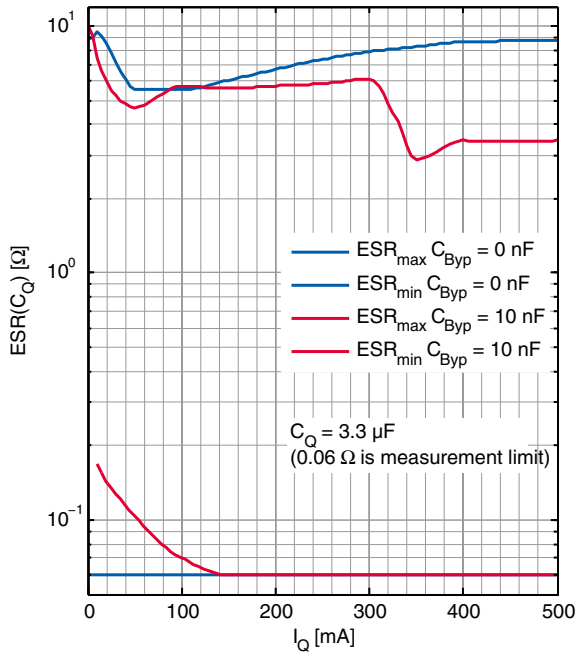


Adjust Pin Bias Current versus Junction Temperature T_J

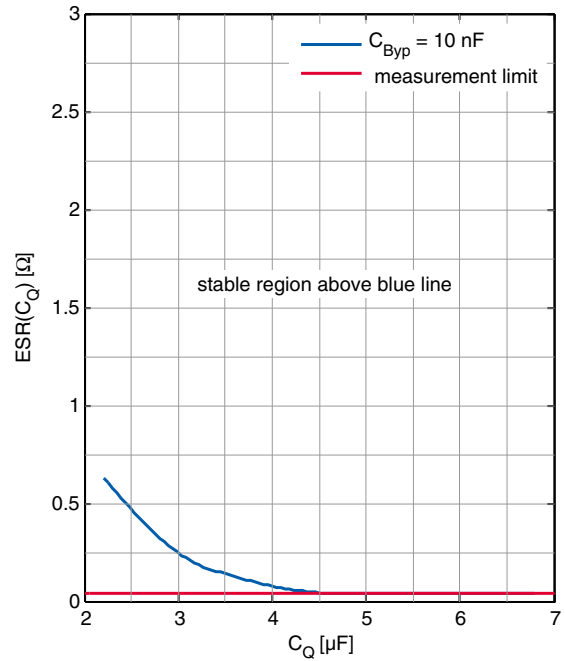


1) $V_{I,min}$ is referred here as the minimum input voltage for which the requested current is provided and V_Q reaches 1 V.

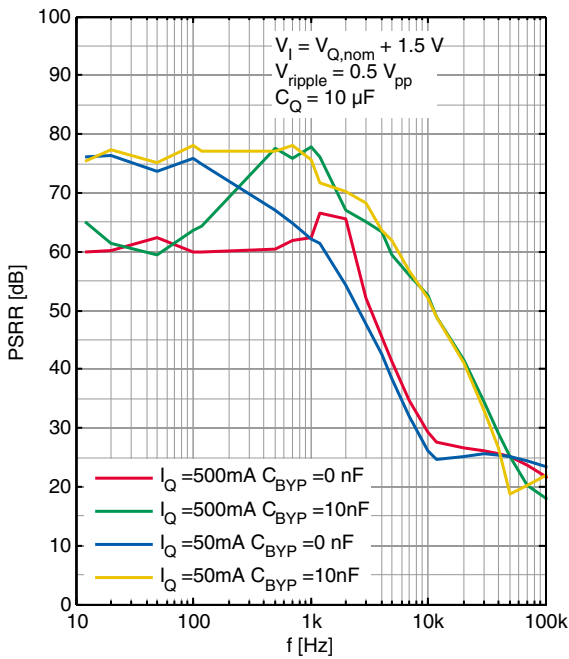
ESR Stability versus Output Current I_Q (for $C_Q = 3.3 \mu\text{F}$)



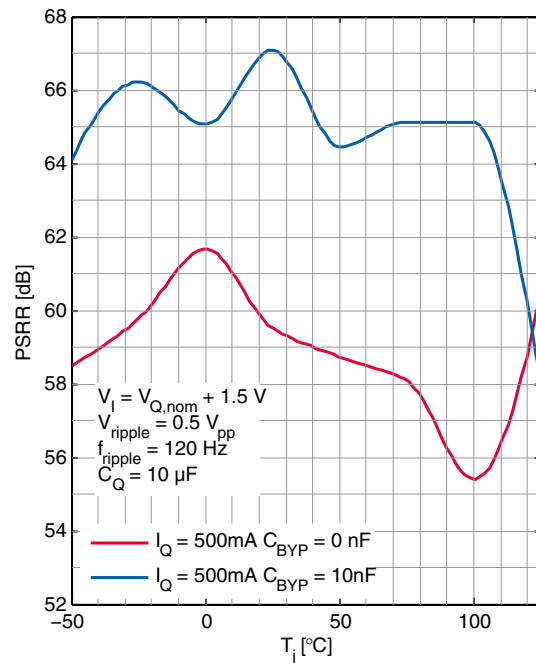
ESR(C_Q) with $C_{BYP} = 10 \text{ nF}$ versus Output Capacitance C_Q



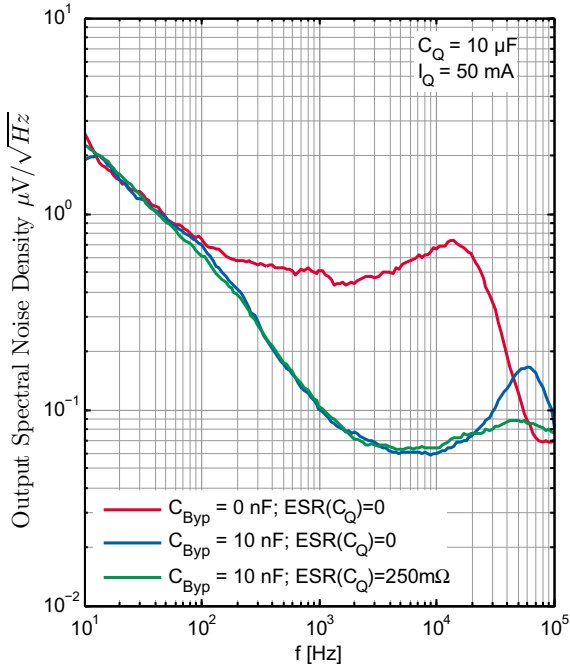
Input Ripple Rejection PSRR versus Frequency f



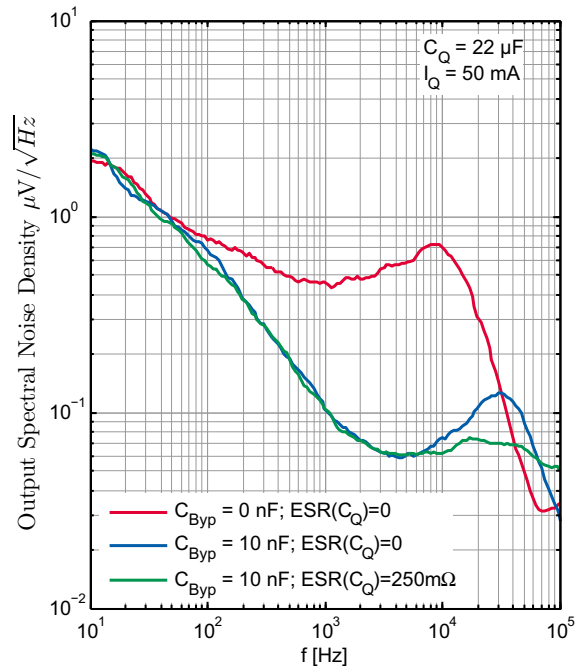
Input Ripple Rejection PSRR versus Junction Temperature T_J



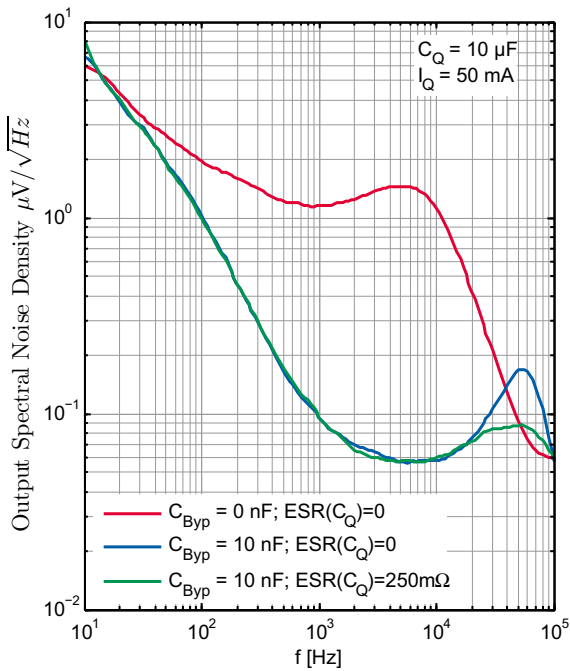
Output Noise Spectral Density (ADJ) versus Frequency f ($C_Q = 10 \mu\text{F}$, $I_Q = 50 \text{ mA}$)



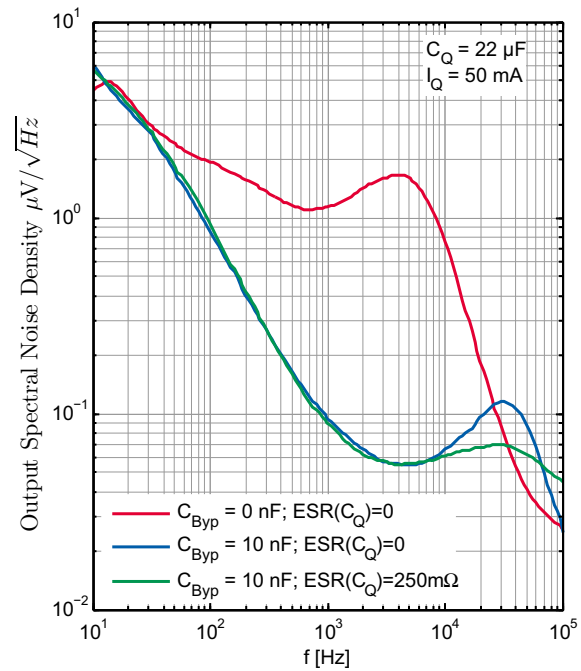
Output Noise Spectral Density (ADJ) versus Frequency f ($C_Q = 22 \mu\text{F}$, $I_Q = 50 \text{ mA}$)



Output Noise Spectral Density (3.3V) versus Frequency f ($C_Q = 10 \mu\text{F}$, $I_Q = 50 \text{ mA}$)

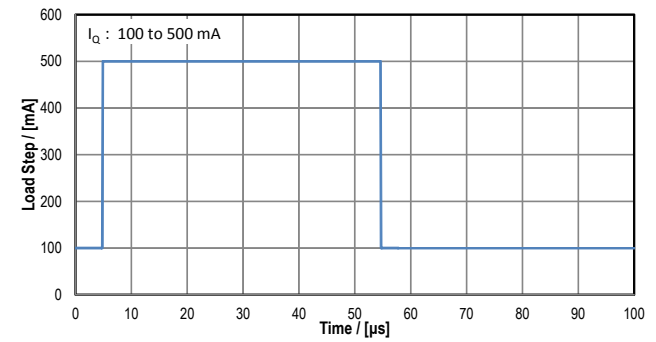
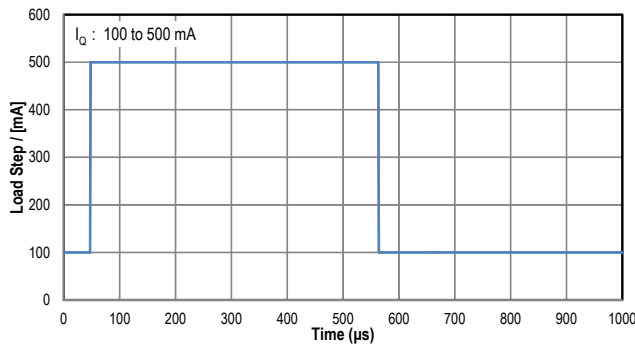
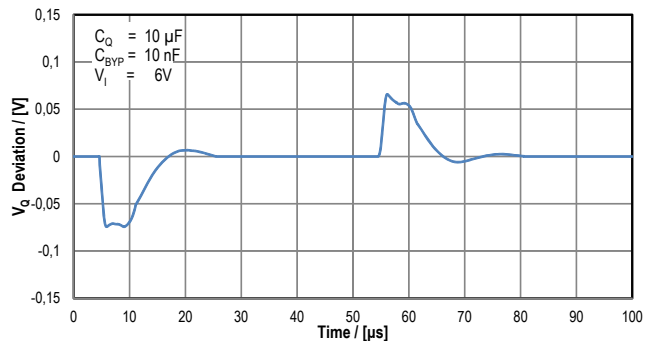
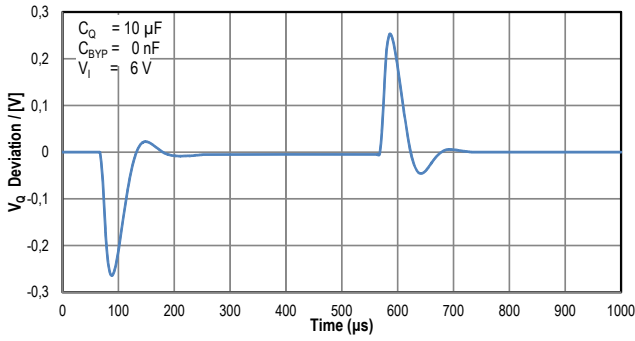


Output Noise Spectral Density (3.3V) versus Frequency f ($C_Q = 22 \mu\text{F}$, $I_Q = 50 \text{ mA}$)



Transient Response $C_{BYP} = 0$ nF (TLS205B0EJV33)

Transient Response $C_{BYP} = 10$ nF (TLS205B0EJV33)



6 Application Information

Note: The following information is given as a hint for the implementation of the device only and shall not be regarded as a description or warranty of a certain functionality, condition or quality of the device.

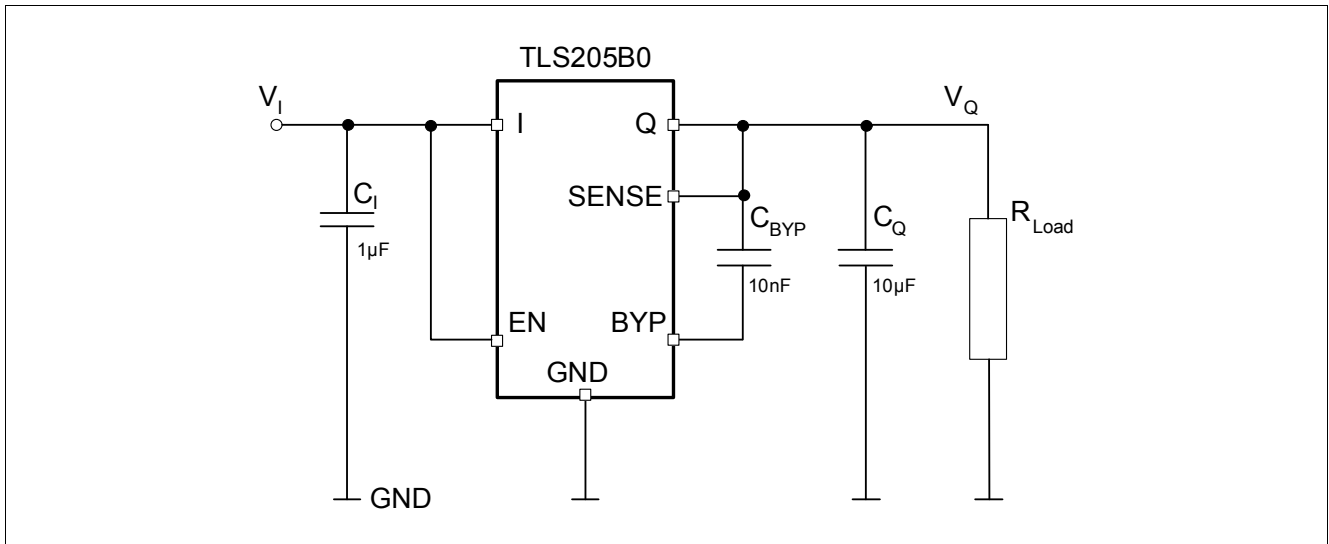


Figure 4 Typical Application Circuit TLS205B0 (fixed voltage version)

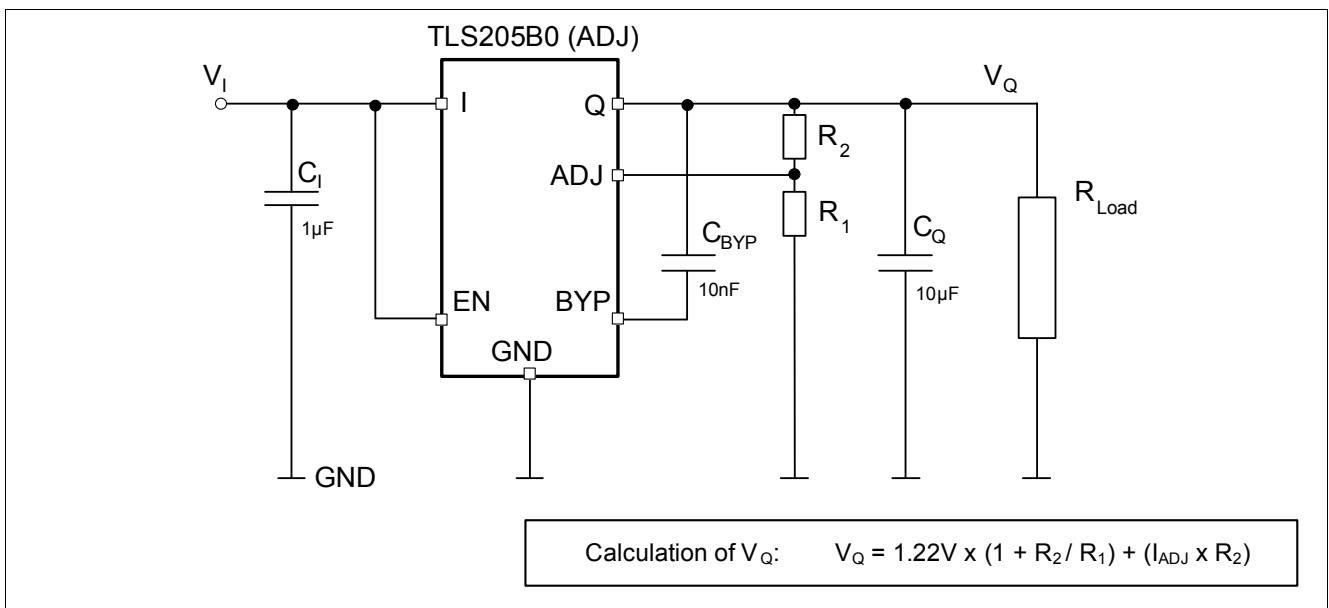


Figure 5 Typical Application Circuit TLS205B0 (adjustable version)

Note: This is a very simplified example of an application circuit. The function must be verified in the real application.¹⁾²⁾

- 1) Please note that in case a non-negligible inductance at the input pin I is present, e.g. due to long cables, traces, parasitics, etc, a bigger input capacitor C_I may be required to filter its influence. As a rule of thumb if the I pin is more than six inches away from the main input filter capacitor an input capacitor value of $C_I = 10 \mu F$ is recommended.
- 2) For specific needs a small optional resistor may be placed in series to very low ESR output capacitors C_Q for enhanced noise performance (for details please see ["Bypass Capacitance and Low Noise Performance"](#) on Page 24).

The TLS205B0 is a 500 mA low dropout regulator with very low quiescent current and Enable-functionality. The device is capable of supplying 500 mA at a dropout voltage of 320 mV. Output voltage noise numbers down to $24 \mu V_{RMS}$ can be achieved over a 10 Hz to 100 kHz bandwidth with the addition of a 10 nF reference bypass capacitor. The usage of a reference bypass capacitor will additionally improve transient response of the regulator, lowering the settling time for transient load conditions. The device has a low operating quiescent current of typical 30 μA that drops to less than 1 μA in shutdown (EN-pin pulled to low level). The device also incorporates several protection features which makes it ideal for battery-powered systems. It is protected against both reverse input and reverse output voltages.

6.1 Adjustable Operation

The adjustable version of the TLS205B0 has an output voltage range of 1.22 V to $20 V - V_{DR}$. The output voltage is set by the ratio of two external resistors, as it can be seen in [Figure 5](#). The device controls the output to maintain the ADJ pin at 1.22 V referenced to ground. The current in R1 is then equal $1.22 V / R1$ and the current in R2 equals the current in R1 plus the ADJ pin bias current. The ADJ pin bias current, which is $\sim 60 \text{ nA}$ @ 25 °C, flows through R2 into the ADJ pin. The value of R1 should be not greater than 250 k Ω in order to minimize errors in the output voltage caused by the ADJ pin bias current. Note that when the device is shutdown (i.e. low level applied to EN pin) the output is turned off and consequently the divider current will be zero. For details of the ADJ Pin Bias current see also the corresponding typical performance graph “[Adjust Pin Bias Current versus Junction Temperature \$T_J\$](#) ” on [Page 19](#).

6.2 Kelvin Sense Connection

For the fixed voltage version of the TLS205B0 the SENSE pin is the input to the error amplifier. An optimum regulation will be obtained at the point where the SENSE pin is connected to the output pin Q of the regulator. In critical applications however small voltage drops may be caused by the resistance R_p of the PC-traces and thus may lower the resulting voltage at the load. This effect may be eliminated by connecting the SENSE pin to the output as close as possible at the load (see [Figure 6](#)). Please note that the voltage drop across the external PC trace will add up to the dropout voltage of the regulator.

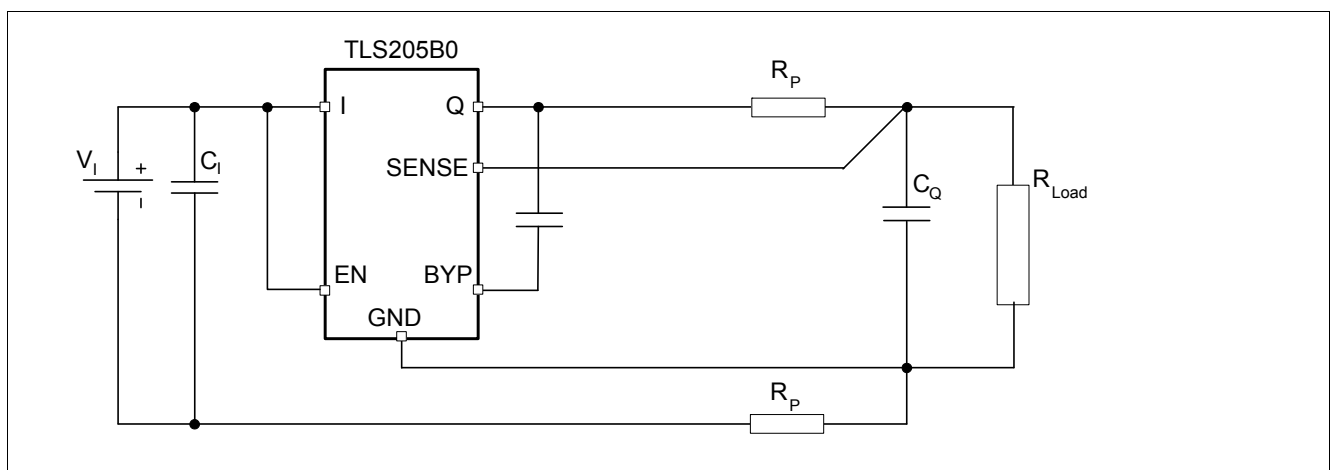


Figure 6 Kelvin Sense Connection

6.3 Bypass Capacitance and Low Noise Performance

The TLS205B0 regulator may be used in combination with a bypass capacitor connecting the output pin Q to the BYP pin in order to minimize output voltage noise¹⁾. This capacitor will bypass the reference of the regulator, providing a low frequency noise pole. The noise pole provided by such a bypass capacitor will lower the output

1) a good quality low leakage capacitor is recommended.

voltage noise in the considered bandwidth. For a given output voltage actual numbers of the output voltage noise will - next to the bypass capacitor itself - be dependent on the capacitance of the applied output capacitor C_Q and its ESR: In case of the TLS205B0EJV applied with unity gain (i.e. $V_Q = 1.22V$) the usage of a bypass capacitor of 10 nF in combination with a (low ESR) ceramic C_Q of 10 μF will result in output voltage noise numbers of typical 41 μV_{RMS} . This Output Noise level can be reduced to typical 28 μV_{RMS} under the same conditions by adding a small resistor of ~ 250 m Ω in series to the 10 μF ceramic output capacitor acting as additional ESR. A reduction of the output voltage noise can also be achieved by increasing capacitance of the output capacitor. For $C_Q = 22$ μF (ceramic low ESR) the output voltage noise will be typically around 29 μV_{RMS} and can again be further lowered to 24 μV_{RMS} by adding a small resistance of ~ 250 m Ω in series to C_Q . In case of the fix voltage version TLS205B0EJV33 the output voltage noise for the described cases vary from 45 μV_{RMS} down to 30 μV_{RMS} . For further details please also see **“Output Voltage Noise ¹⁰⁾” on Page 11**, of the Electrical Characteristics. Please note that next to reducing the output voltage noise level the usage of a bypass capacitor has the additional benefit of improving transient response which will be also explained in the next chapter. However one needs to take into consideration that on the other hand the regulator start-up time is proportional to the size of the bypass capacitor and slows down to values around 15 ms when using a 10 nF bypass capacitor in combination with a 10 μF C_Q output capacitor.

6.4 Output Capacitance and Transient Response

The TLS205B0 is designed to be stable with a wide range of output capacitors. The ESR of the output capacitor is an essential parameter with regard to stability, most notably with small capacitors. A minimum output capacitor of 3.3 μF with an ESR of 3 Ω or less is recommended to prevent oscillations. Like in general for LDO's the output transient response of the TLS205B0 will be a function of the output capacitance. Larger values of output capacitance decrease peak deviations and thus improve transient response for larger load current changes. Bypass capacitors, used to decouple individual components powered by the TLS205B0 will increase the effective output capacitor value. Please note that with the usage of bypass capacitors for low noise operation either larger values of output capacitors may be needed or a minimum ESR requirement of C_Q may have to be considered (see also typical performance graph **“ESR(C_Q) with $C_{BYP} = 10$ nF versus Output Capacitance C_Q ” on Page 20** as example). In conjunction with the usage of a 10 nF bypass capacitor an output capacitor $C_Q \geq 6.8$ μF is recommended. The benefit of a bypass capacitor to the transient response performance is impressive and illustrated as one example in **Figure 7** where the transient response of the TLS205B0EJV33 to one and the same load step from 100 mA to 500 mA is shown with and without a 10 nF bypass capacitor: for the given configuration of $C_Q = 10$ μF with no bypass capacitor the load step will settle in the range of less than 100 μs while for $C_Q = 10$ μF in conjunction with a 10 nF bypass capacitor the same load step will settle in the range of 10 μs . Due to the shorter reaction time of the regulator by adding the bypass capacitor not only the settling time improves but also output voltage deviations due to load steps are sharply reduced.

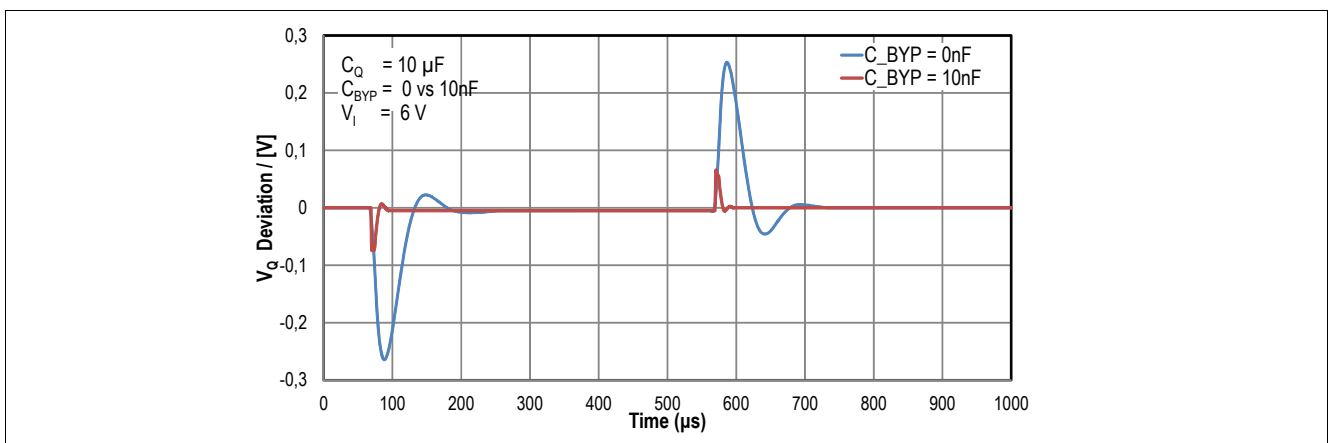


Figure 7 Influence of C_{BYP} : example of transient response to one and the same load step with and without C_{BYP} of 10 nF (I_Q : 100 mA to 500 mA, TLS205B0EJV33)

6.5 Protection Features

The TLS205B0 regulators incorporate several protection features which make them ideal for use in battery-powered circuits. In addition to normal protection features associated with monolithic regulators like current limiting and thermal limiting the device is protected against reverse input voltage, reverse output voltage and reverse voltages from output to input.

Current limit protection and thermal overload protection are intended to protect the device against current overload conditions at the output of the device. For normal operation the junction temperature must not exceed 125 °C.

The input of the device will withstand reverse voltages of 20 V. Current flowing into the device will be limited to less than 1 mA (typically less than 100 µA) and no negative voltage will appear at the output. The device will protect both itself and the load. This provides protection against batteries being plugged backwards.

The output of the TLS205B0 can be pulled below ground without damaging the device. If the input is left open-circuit or grounded, the output can be pulled below ground by 20 V. Under such conditions the output of the device by itself behaves like an open circuit with practically no current flowing out of the pin ¹⁾. In more application relevant cases however where the output is either connected to the SENSE pin (fix voltage variant) or tied either via an external voltage divider or directly to the ADJ pin (adjustable variant) a small current will be present from this origin. In the case of the fixed voltage version this current will typically be below 100 µA while for the adjustable version it depends on the magnitude of the top resistor of the external voltage divider ²⁾. If the input is powered by a voltage source the output will source the short circuit current of the device and will protect itself by thermal limiting. In this case grounding the EN pin will turn off the device and stop the output from sourcing the short-circuit current.

The ADJ pin of the adjustable device can be pulled above or below ground by as much as 7 V without damaging the device. If the input is grounded or left open-circuit, the ADJ pin will act inside this voltage range like a large resistor (typically 100 kΩ) when being pulled above ground and like a resistor (typically 5 kΩ) in series with a diode when being pulled below ground. In situations where the ADJ pin is at risk of being pulled outside its absolute maximum ratings ±7 V the ADJ pin current must be limited to 1 mA (e.g. in cases where the ADJ pin is connected to a resistor divider that would pull the ADJ pin above its 7 V clamp voltage). Let's consider for example the case where a resistor divider is used to provide a 1.5 V output from the 1.22 V reference and the output is forced to 20 V. The top resistor of the resistor divider must then be chosen to limit the current into the ADJ pin to 1 mA or less when the ADJ pin is at 7 V. The 13 V difference between output and ADJ pin divided by the 1 mA maximum current into the ADJ pin requires a minimum resistor value of 13 kΩ.

In circuits where a backup battery is required, several different input/output conditions can occur. The output voltage may be held up while the input is either pulled to ground, pulled to some intermediate voltage or is left open-circuit. Current flow back into the output will follow the curve as shown in [Figure 8](#) below.

1) typically < 1 µA for the mentioned conditions, V_Q being pulled below ground with other pins either grounded or open.

2) In case there is no external voltage divider applied i.e. the ADJ pin is directly connected to the output Q and the output is pulled below ground by 20 V the current flowing out of the ADJ pin will be typically ~ 4 mA. Please ensure in such cases that the absolute maximum ratings of the ADJ pin are respected.

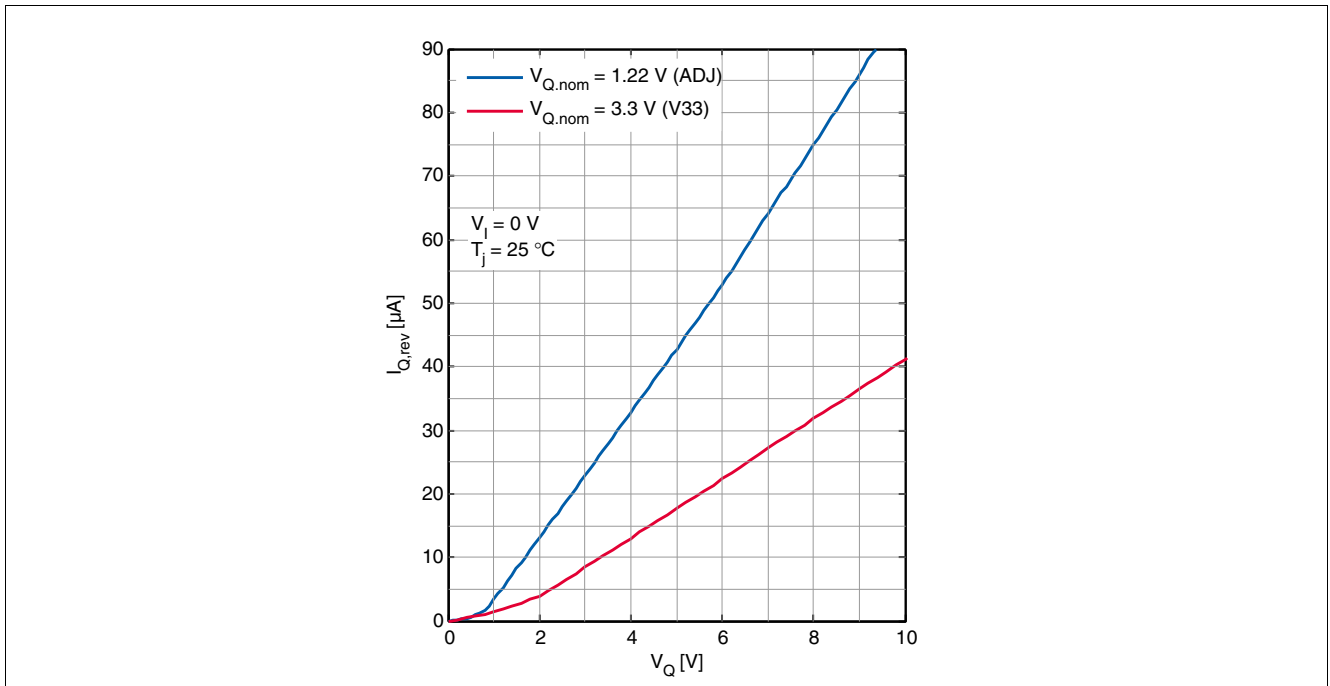


Figure 8 Reverse Output Current

7 Package Outlines

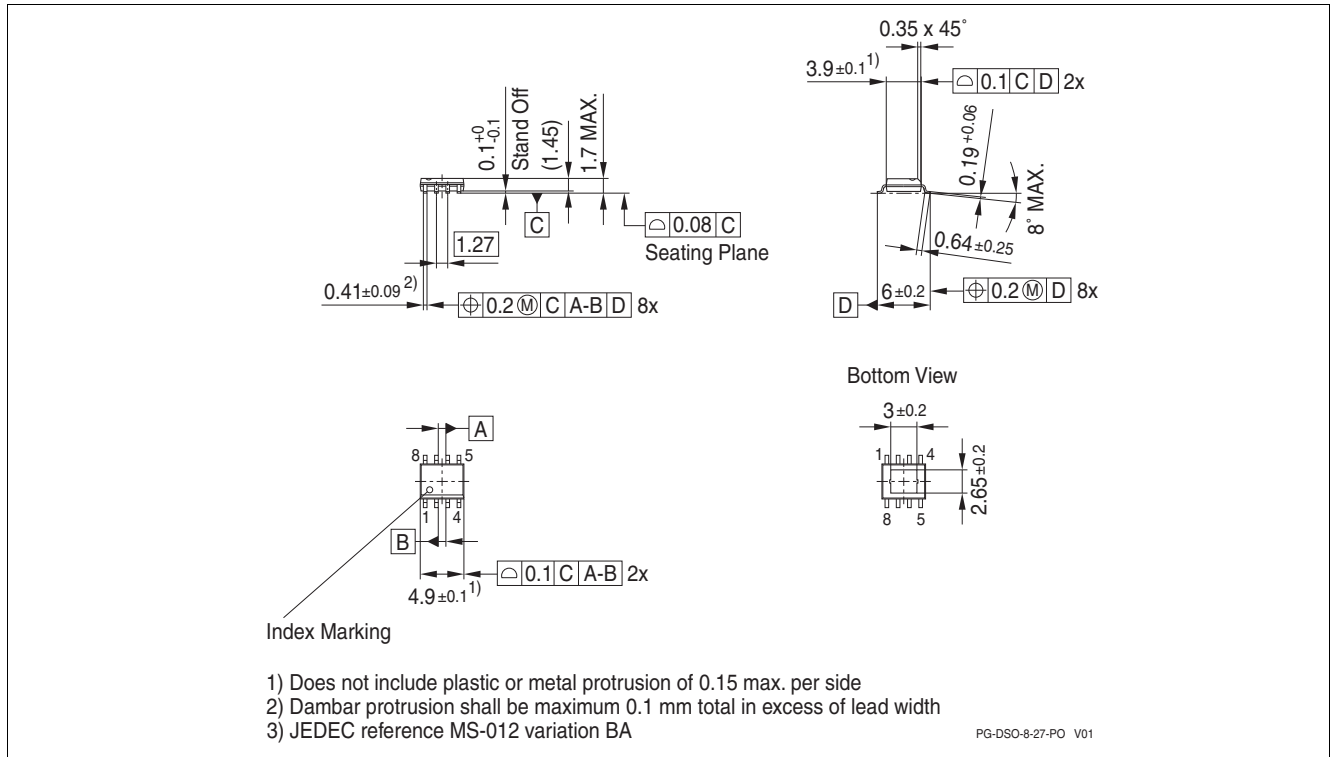


Figure 9 PG-DSO-8 Exposed Pad package outlines

Green Product (RoHS compliant)

To meet the world-wide customer requirements for environmentally friendly products and to be compliant with government regulations the device is available as a green product. Green products are RoHS-Compliant (i.e Pb-free finish on leads and suitable for Pb-free soldering according to IPC/JEDEC J-STD-020).

8 Revision History

Revision	Date	Changes
1.1	2014-06-03	Data Sheet - Revision 1.1: <ul style="list-style-type: none">• Order of footnotes in Table 3 “Thermal Resistance” on Page 9 corrected.• Application Information Chapter 6.5 updated: Clarification and correction of wording. Typical values updated and footnotes added.• Editorial changes.
1.0	2014-02-27	Data Sheet - Initial Release

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